Perspectives on PFOS*

*PerFluoroOctyl Sulfonate

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Overview

- Background
- Semiconductor Technology Perspective
- Opportunities for University (ERC) research

Classical Train Wreck Problem

- Concern regarding the potential environmental and human health impacts attributed to [*target chemical*] drive regulatory actions by governments.
- Continued success of the global semiconductor industry depends on the availability of [*target chemical*] for critical uses.

Public Policy Context

- Increasing tendency of public and governments to focus on intrinsic properties of substances (*hazard*) rather than likelihood of exposure (*risk*)
- Gaining popularity of *precaution* as basic regulatory approach
- Analytical ability to detect chemicals at extremely low concentrations

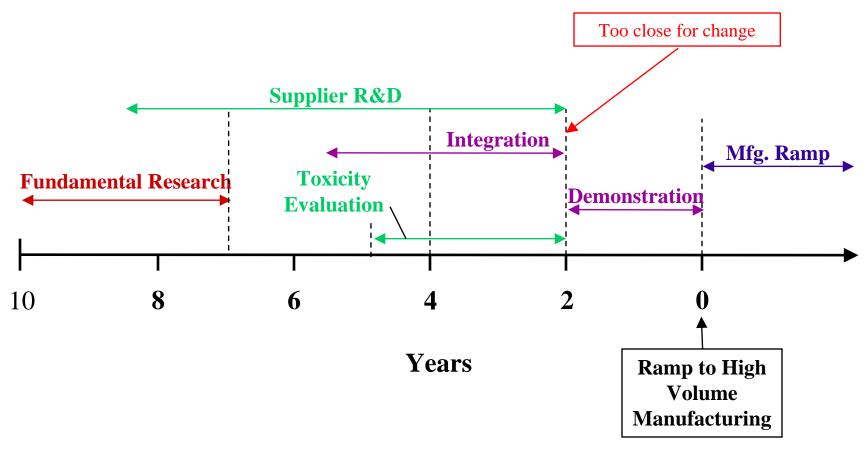
Technology Planning Context

- As circuit widths continue to decrease, novel chemicals become more important to our ability to maintain Moore's Law
- Bans and phase-outs reduce our product and process design flexibility
- Need to get regulatory approvals for chemicals threatens cycle time delays

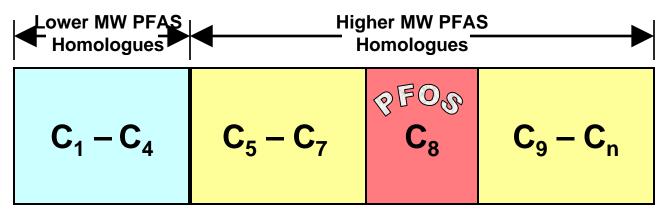
The Semiconductor Technology Development Cycle

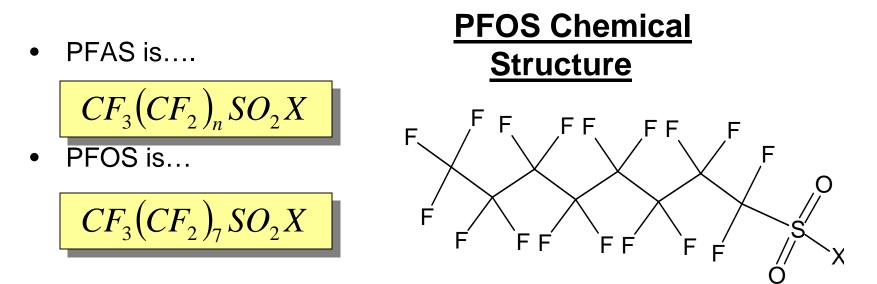
- The semiconductor manufacturing process is highly complex
- As circuit features get ever smaller, specialty chemicals like PFOS become ever more important
- Chemicals and materials must work precisely with advanced equipment ("tools") to accomplish high-yield, high-volume manufacturing
- The process for developing new chemicals, new tools, and to ensure that the two work together in a manufacturing environment can take 10-15 years to complete
- Substitution of new materials into an existing process cannot happen quickly

Technology Development Cycle



Definitions





MW = Molecular Weight

Policy Actions RE: PFOS

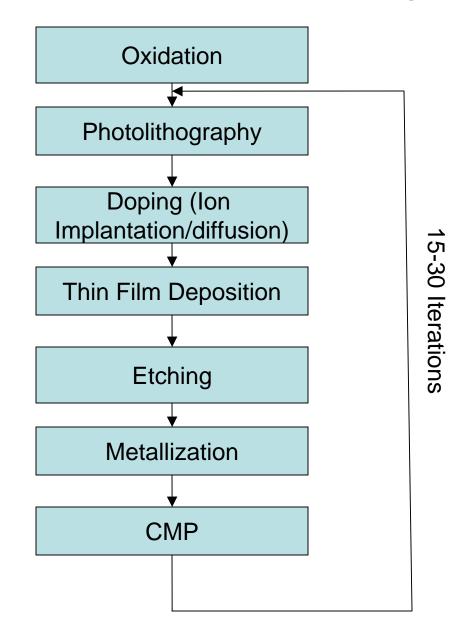
- Supplier withdrawals from the market due to concern over environmental persistence and bioaccumulation plus potential for toxicity
 - 3M (2000), DNI (2003)
- EPA issued a SNUR (Significant New Use Rule) covering PFOS compounds (2000)
 - Bans manufacturing (importation) after 2002
 - Limited exemption for "critical" photolithography uses in the semiconductor industry – photoresists, ARCs, and surfactants
- Further Regulatory/governmental actions
 - PFOA risk assessment (EPA)
 - PFOS risk assessment (EPA) timing uncertain, but on slow track
 - UK Risk Reduction Strategy restrictions/exemption by end of 2005
 - EU Commission (Marketing & Use Exemption)
 - OSPAR follow UK result
 - SNUR II rule (Potential incorporation of PFAS)

Industry Response

- End all non-critical uses of PFOS
- Work towards phase-out of PFOS in critical applications
- Undertake research and development to identify potential PFOS substitutes outside the universe of organic perfluorinated chemistry
- Insure that releases to the environment are *de minimis*

"Critical" vs. "Non-Critical" PFOS Uses

- The distinction between "critical" and "non-critical" revolves around the availability, or expected availability, of technically-adequate substitutes where PFOS makes a unique contribution to the manufacturing process
- Remaining PFOS uses in semiconductor manufacturing are those for which there are no readily available substitutes, e.g., PAGs and ARCs
- Finding substitutes for all critical PFOS uses will take many years of basic research through to qualification and high-volume manufacturing
 - Among the issues to be faced
 - Highly competitive industry;
 - Confidentiality issues;
 - Information not readily available
 - Because of low volumes, supplier interest mixed

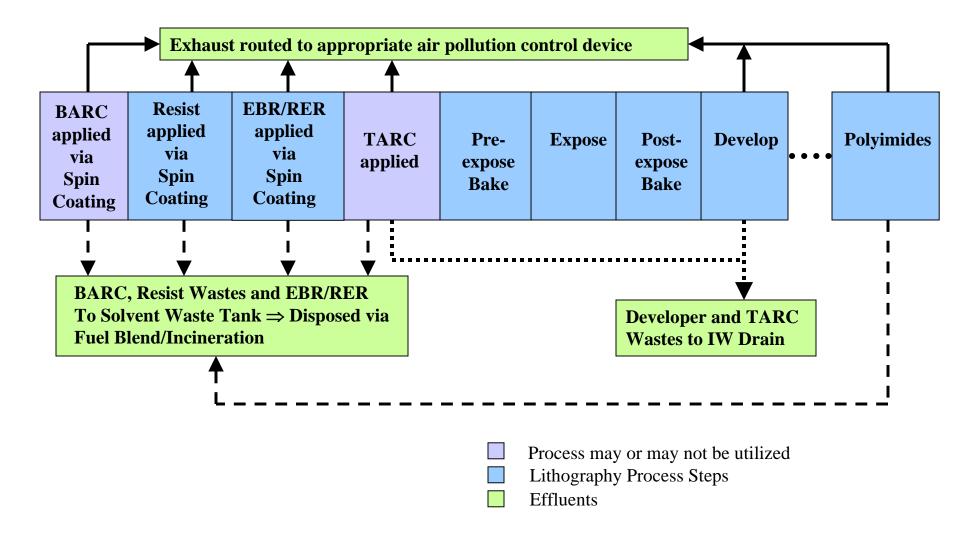


Basic Steps in Semiconductor Manufacturing

Why Are PFOS Compounds Used in Photolithography

- Photoacid Generators
 - Photoresists for 248nm and shorter wavelengths rely on chemical amplification
 - During exposure the photo-acid generator forms an acid catalyst which aids in creating the desired image
 - Photo-acid generators used for this purpose are typically sulfonic acids
 - PFOS is currently the ONLY chemical that can provide the necessary acidity
- Anti-Reflective Coatings
 - Refractive index (RI) must be as close as possible to the square root of the photoresist RI.
 - Only fluorinated materials can meet this requirement
- PFOS-based Surfactants
 - Surface tension can produce thickness variations that emanate from the center of the wafer during the spin-on application of the resist
 - PFOS-based surfactants are particularly effective in:
 - Lowering the surface tension
 - Reducing thickness variation
 - Creating more uniform films

Typical Photolithography Process Life Cycle



The PFOS Substitution Process

Considerable engineering is required to make the PFOS-free alternatives work in manufacturing; they are not "drop-in" replacements.

- A semiconductor process technology is a combination of 100-400 steps that are all somewhat dependent on each other. A technology is unique from another technology because any or all of the steps are different, as well as their processing parameters (e.g. feature size)
- Thus, a lithography step in one technology is not equivalent to another technology, although sometimes they are a little similar.
- Introducing a new resist requires an extensive qualification for each technology use. Up to 20 different resist uses could exist in one technology.
- This qualification is costly and involves many engineers.
 - If development engineers are working primarily on legacy resists, they cannot work on the newest technologies and the total technology development timeline will be impacted.

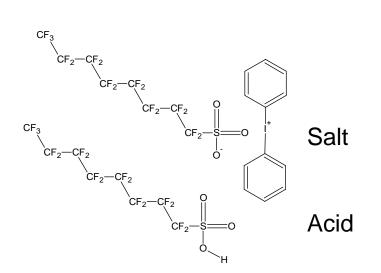
TECHNICAL CHALLENGES

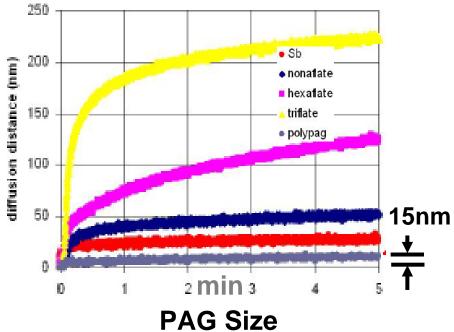
- Finding and qualifying non-PFOS substitutes for use in critical applications (PAGs and ARCs)
 - Initially mostly PFAS materials
- Finding non-perfluorinated substitutes
- Implementing waste stream segregation and treatment technology to eliminate all PFOS/PFAS/PFOA effluents
 - This will increase prospects for continuing exemptions while we exit perfluorinated chemistry
 - Support obtaining broad regulatory exemption for our chemical use based on "highly-controlled industrial process" model

Sample Problem - PAGs

Why PFOS PAG? •Strong Acid •Miscible with many materials •Big

Why not PFOS? •POP concern •Fluorous Self Assembly •EUV transparency •15nm diffusion for even larger





Effect of Counter Ion Size

Willson, 2003 SRC/DARPA Review, reproduced by permission PFOS PAG Replacement Technology options

Why is PFOS good for resist catalyst?

•F increases strength of sulfonic acid

•Nonpolar tail (C7F15) associates with polymers like acrylates & styrene

Why is PFOS not good for environment?

•Perfluoro- compounds don't degrade easily

- •PFOS associates with protein in the blood
- •Polar bears, Cormorants, EU ministers

What else instead?

- •Other electronegative atoms/groups for acid strength
- •Re-engineer resist to bind acid (15nm limit, clusters)
- •Re-engineer resist so a weaker catalyst is ok

•Remove the PFOS from the waste (stop-gap)

